

<b>Notice of References Cited</b>	Application/Control No. 09/883,766	Applicant(s)/Patent Under Reexamination TRAN, THANH T.	
	Examiner Annan Q. Shang	Art Unit 2617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,175,871	01-2001	Schuster et al.	709/231
	B	US-6,704,021	03-2004	Rogers et al.	345/543
	C	US-6,625,709	09-2003	Aiken et al.	711/170
	D	US-6,594,329	07-2003	Susnow, Dean S.	375/372
	E	US-6,594,329	07-2003	Susnow, Dean S.	375/372
	F	US-6,230,220	05-2001	Cohen et al.	710/52
	G	US-6,253,262	06-2001	Rozario et al.	710/39
	H	US-5,916,309	06-1999	Brown et al.	710/52
	I	US-5,781,533	07-1998	Manning et al.	370/236
	J	US-6,470,376	10-2002	Tanaka et al.	718/108
	K	US-6,609,253	08-2003	Swix et al.	725/88
	L	US-5,821,889	10-1998	Miller, Gary L.	341/139
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.